# imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



# Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832 Email & Skype: info@chipsmall.com Web: www.chipsmall.com Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China





# Trench gate field-stop IGBT, M series 650 V, 50 A low-loss in a TO-247 long leads package

Datasheet - production data

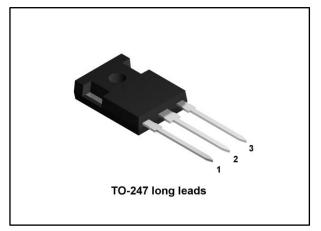
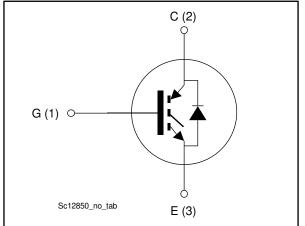


Figure 1: Internal schematic diagram



## **Features**

- 6 µs of minimum short-circuit withstand time
- V<sub>CE(sat)</sub> = 1.65 V (typ.) @ I<sub>C</sub> = 50 A
- Tight parameters distribution
- Safer paralleling
- Positive V<sub>CE(sat)</sub> temperature coefficient
- Low thermal resistance
- Soft and very fast recovery antiparallel diode
- Maximum junction temperature: T<sub>J</sub> = 175 °C

## **Applications**

- Motor control
- UPS
- PFC
- General purpose inverter

## Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where low-loss and short-circuit functionality are essential. Furthermore, the positive  $V_{CE(sat)}$  temperature coefficient and tight parameter distribution result in safer paralleling operation.

## Table 1: Device summary

Order code Marking		Package	Packing
STGWA50M65DF2	G50M65DF2	TO-247 long leads	Tube

This is information on a product in full production.

## Contents

## Contents

1	Electric	cal ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	rcuits	12
4	Packag	e mechanical data	13
	4.1	Package information	13
5	Revisio	on history	15



## 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
VCES	Collector-emitter voltage (V <sub>GE</sub> = 0 V)	650	V
lc <sup>(1)</sup>	Continuous collector current at $T_C = 25$ °C	80	А
lc	Continuous collector current at T <sub>c</sub> = 100 °C	50	А
Icp <sup>(2)</sup>	Pulsed collector current	150	А
$V_{\text{GE}}$	Gate-emitter voltage	±20	V
۱ <sub>۲</sub> (1)	Continuous forward current at $T_c = 25 \text{ °C}$	80	А
IF	I <sub>F</sub> Continuous forward current at T <sub>C</sub> = 100 °C		А
I <sub>FP</sub> <sup>(2)</sup>	Pulsed forward current	150	А
Ртот	$P_{TOT}$ Total dissipation at $T_c = 25 \ ^{\circ}C$		W
Tstg	T <sub>STG</sub> Storage temperature range		°C
TJ	Operating junction temperature range	- 55 to 175	°C

### Notes:

<sup>(1)</sup>Current level is limited by bond wires.

 $\ensuremath{^{(2)}}\ensuremath{\mathsf{Pulse}}$  width limited by maximium junction temperature.

### Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>thJC</sub> Thermal resistance junction-case IGBT		0.4	°C/W
R <sub>thJC</sub>	R <sub>thJC</sub> Thermal resistance junction-case diode		°C/W
RthJA Thermal resistance junction-ambient		50	°C/W



# 2 Electrical characteristics

 $T_C = 25$  °C unless otherwise specified

	I able 4: Static characteristics					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$V_{(BR)CES}$	Collector-emitter breakdown voltage	$V_{GE}=0~V,~I_C=250~\mu A$	650			V
		$V_{GE} = 15 \text{ V}, \text{ I}_{C} = 50 \text{ A}$		1.65	2.1	
V <sub>CE(sat)</sub>	Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, Ic = 50 A, T <sub>J</sub> = 125 °C		1.95		v
		$V_{GE} = 15 \text{ V}, \text{ I}_{C} = 50 \text{ A},$ T <sub>J</sub> = 175 °C		2.1		
	Forward on-voltage	IF = 50 A		1.85	2.65	
VF		I <sub>F</sub> = 50 A, T <sub>J</sub> = 125 °C		1.65		V
		I⊧ = 50 A, TJ = 175 °C		1.55		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}, I_C = 1 \text{ mA}$	5	6	7	V
ICES	Collector cut-off current	$V_{GE} = 0 V, V_{CE} = 650 V$			25	μA
I <sub>GES</sub>	Gate-emitter leakage current	$V_{CE}=0~V,~V_{GE}=\pm~20~V$			±250	μΑ

## Table 4: Static characteristics

## Table 5: Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Cies	Input capacitance		-	4200	-	
Coes	Output capacitance	V <sub>CE</sub> = 25 V, f = 1 MHz,	-	252	-	рF
Cres	Reverse transfer capacitance	V <sub>GE</sub> = 0 V	-	88	-	P
Qg	Total gate charge	Vcc = 520 V, Ic = 50 A,	-	150	-	
Q <sub>ge</sub>	Gate-emitter charge	V <sub>GE</sub> = 0 to 15 V (see <i>Figure 30:</i> " <i>Gate</i>	-	32	-	nC
Q <sub>gc</sub>	Gate-collector charge	charge test circuit")	-	62	-	

## Electrical characteristics

	Table 6: IGBT switching characteristics (inductive load)					
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time			42	-	ns
tr	Current rise time			21	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	V <sub>CE</sub> = 400 V, I <sub>C</sub> = 50 A,		1942	-	A/µs
t <sub>d(off)</sub>	Turn-off-delay time	$V_{GE} = 400 \text{ V}, \text{ IC} = 50 \text{ A},$ $V_{GE} = 15 \text{ V}, \text{ R}_{G} = 6.8 \Omega$		130	-	ns
t <sub>f</sub>	Current fall time	(see Figure 29: " Test circuit		104	-	ns
Eon <sup>(1)</sup>	Turn-on switching energy	for inductive load switching")		0.88	-	mJ
Eoff <sup>(2)</sup>	Turn-off switching energy			1.57	-	mJ
Ets	Total switching energy			2.45	-	mJ
t <sub>d(on)</sub>	Turn-on delay time			42	-	ns
tr	Current rise time			24	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	$V_{CE} = 400 V, I_C = 50 A,$		1700	-	A/µs
t <sub>d(off)</sub>	Turn-off-delay time	V <sub>GE</sub> = 15 V, R <sub>G</sub> = 6.8 Ω, T <sub>J</sub> = 175 °C		131	-	ns
tr	Current fall time	(see Figure 29: " Test circuit		184	-	ns
Eon <sup>(1)</sup>	Turn-on switching energy	for inductive load switching")		1.97	-	mJ
Eoff <sup>(2)</sup>	Turn-off switching energy			2.22	-	mJ
Ets	Total switching energy			4.19	-	mJ
+	Short circuit withstand time	V <sub>CC</sub> ≤ 400 V, V <sub>GE</sub> = 13 V, T <sub>Jstart</sub> ≤ 150 °C	10		-	110
t <sub>sc</sub>	Short-circuit withstand time	V <sub>CC</sub> ≤ 400 V, V <sub>GE</sub> = 15 V, T <sub>Jstart</sub> ≤ 150 °C	6		-	μs

## Notes:

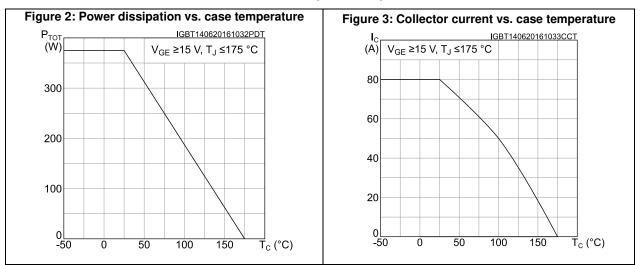
<sup>(1)</sup>Including the reverse recovery of the diode. <sup>(2)</sup>Including the tail of the collector current.

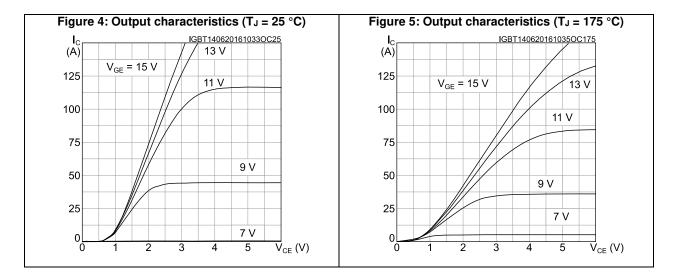
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
trr	Reverse recovery time		-	162	-	ns
Q <sub>rr</sub>	Reverse recovery charge	I <sub>F</sub> = 50 A, V <sub>R</sub> = 400 V,	-	1.37	-	μC
Irrm	Reverse recovery current	V <sub>GE</sub> = 15 V, di/dt = 1000 A/µs	-	19	-	Α
dlrr/dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	(see Figure 29: " Test circuit for inductive load switching")	-	420	-	A/µs
Err	Reverse recovery energy		-	192	-	μJ
trr	Reverse recovery time		-	262	-	ns
Qrr	Reverse recovery charge	I <sub>F</sub> = 50 A, V <sub>R</sub> = 400 V, V <sub>GE</sub> = 15 V,	-	5.1	-	μC
Irrm	Reverse recovery current	di/dt = 1000 A/µs,	-	34	-	А
dlrr/dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	T <sub>J</sub> = 175 °C (see <i>Figure 29: " Test circuit</i> for inductive load switching")	-	160	-	A/µs
Err	Reverse recovery energy	ior madeline load switching )	-	676	-	μJ

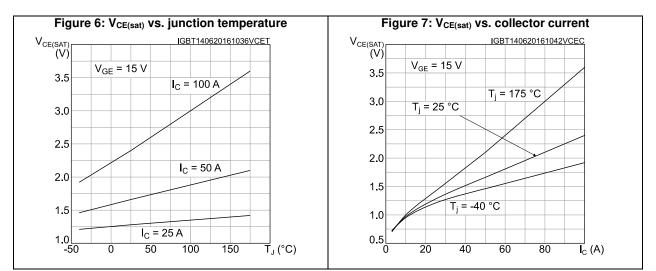
#### Table 7: Diode switching characteristics (inductive load)



## 2.1 Electrical characteristics (curves)



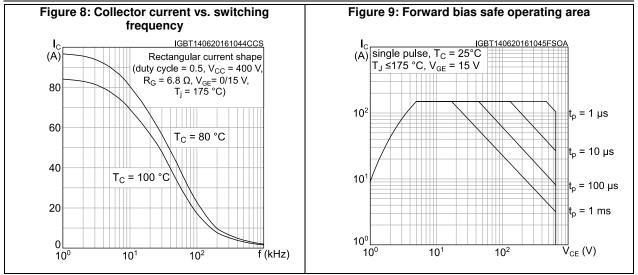


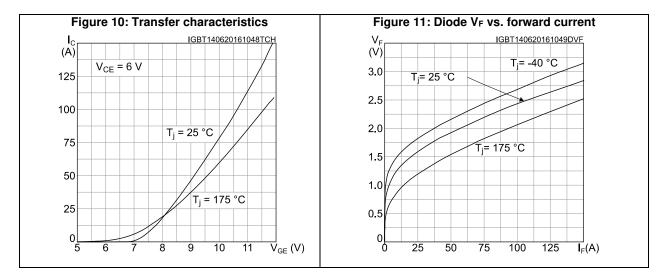


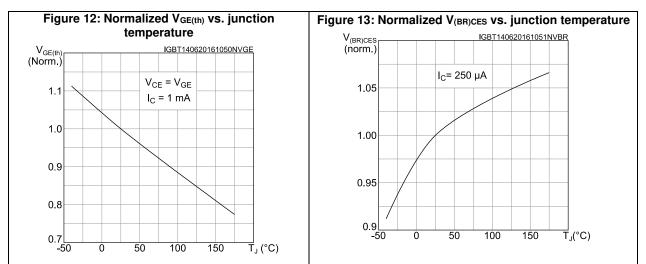


57

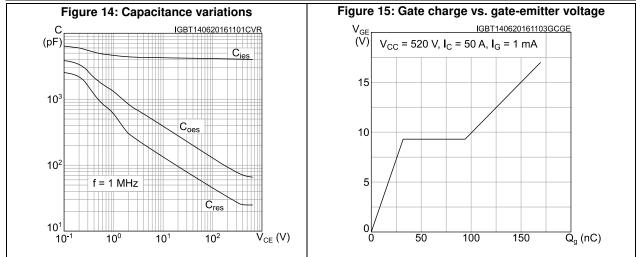
#### **Electrical characteristics**

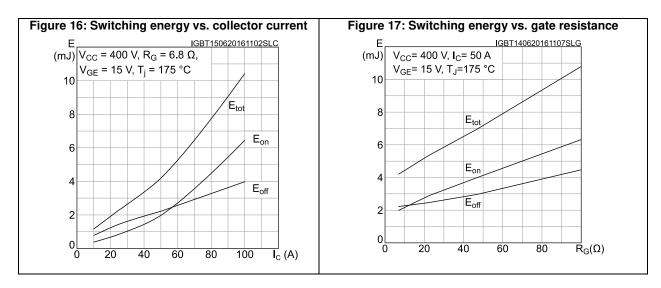


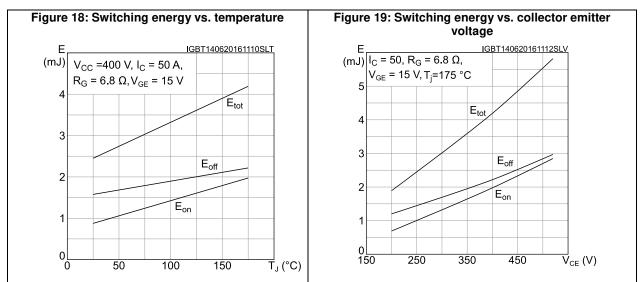








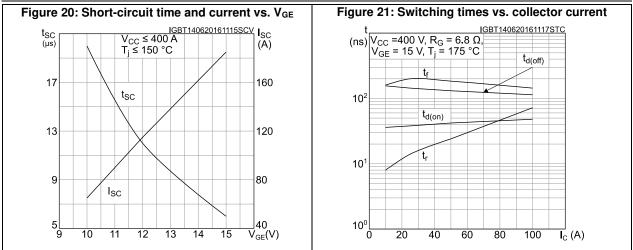


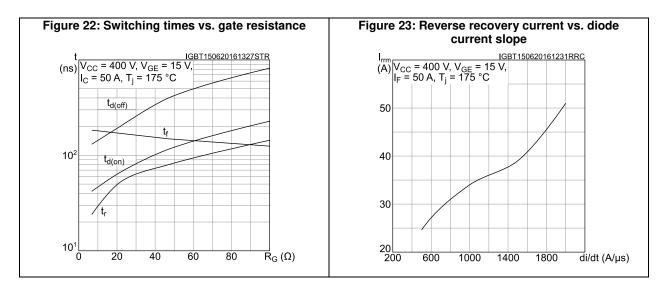


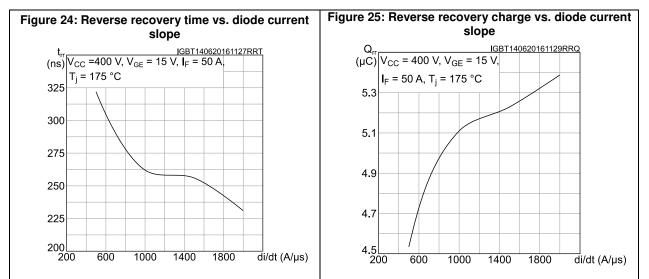


57

### **Electrical characteristics**

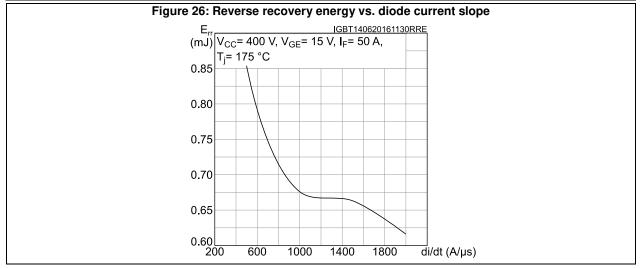


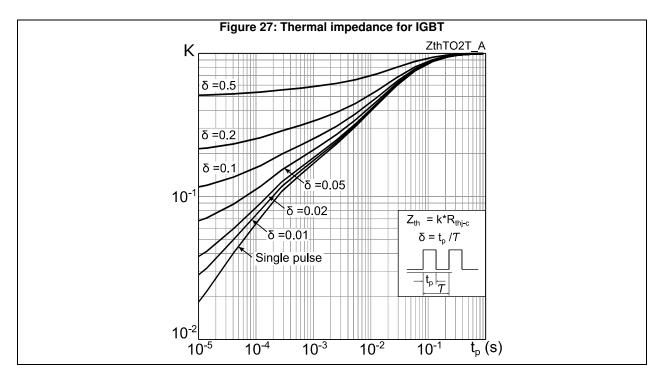




## **Electrical characteristics**

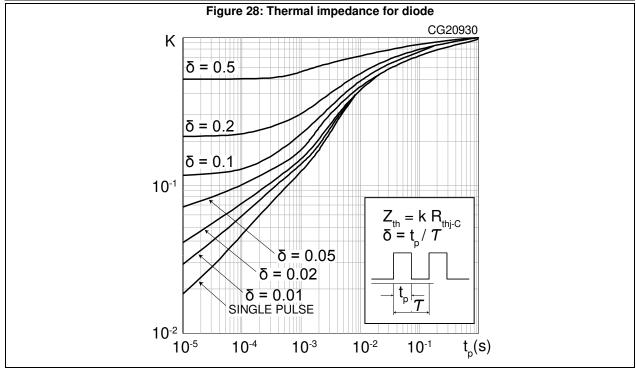
## STGWA50M65DF2





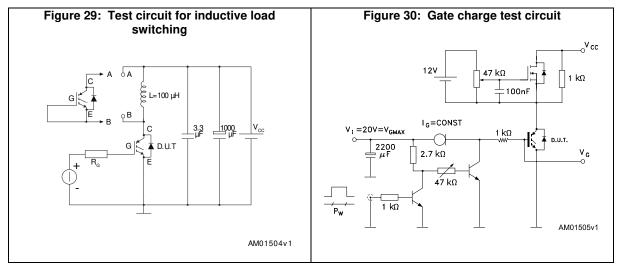


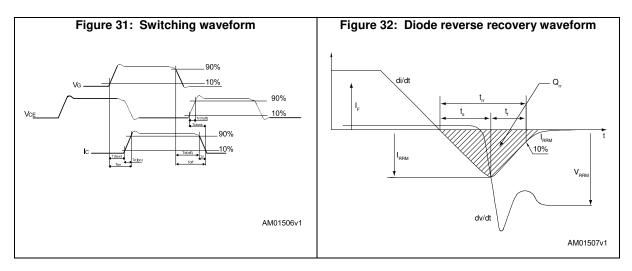
## **Electrical characteristics**





## 3 Test circuits







## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: *www.st.com*. ECOPACK<sup>®</sup> is an ST trademark.

## 4.1 Package information

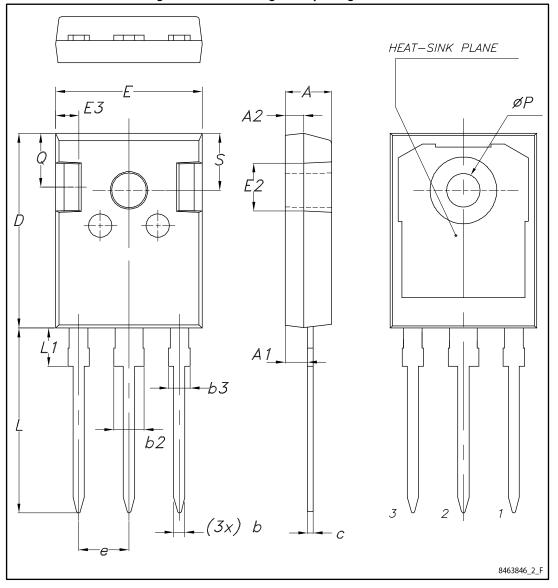


Figure 33: TO-247 long leads package outline



## Package mechanical data

## STGWA50M65DF2

nechanical data	STGWA50M65DF2		
Т	able 8: TO-247 long lead	ls package mechanical d	ata
Dim		mm	
Dim.	Min.	Тур.	Max.
А	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
с	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
е	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
Р	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

14/16 DocID028694 Rev 3



# 5 Revision history

Table 9: Document revisior	n history
----------------------------	-----------

\_\_\_\_\_

Date	Revision	Changes	
27-Nov-2015	1	First release.	
14-Jun-2016	2	Modified: features and applications in cover page Modified: Table 2: "Absolute maximum ratings", Table 4: "Static characteristics", Table 5: "Dynamic characteristics", Table 6: "IGBT switching characteristics (inductive load)", Table 7: "Diode switching characteristics (inductive load)" Added: Section 2.1: "Electrical characteristics (curves)" Minor text changes	
02-May-2017 3		<ul> <li>Modified: title, features and applications on cover page.</li> <li>Modified Table 4: "Static characteristics", Table 7: "Diode switching characteristics (inductive load)" and Figure 13: "Normalized V<sub>(BR)CES</sub> vs. junction temperature ".</li> <li>Updated Section 4: "Package mechanical data".</li> <li>Minor text changes.</li> </ul>	



## IMPORTANT NOTICE – PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2017 STMicroelectronics - All rights reserved

